Carbon coatings on silicon carbide by reaction with chlorine-containing gases

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Carbon films have been produced on the surface of β-SiC particles by reaction with Ar–Cl₂ and Ar–Cl₂–H₂ gas mixtures at atmospheric pressure and temperatures of 600–1000 °C. The structure and composition of the carbon films have been investigated using XRD, SEM, EDS, TEM, FTIR and Raman spectroscopy. BET and TG were also used for measuring the amount of carbon formed in the reaction. Uniform nanoporous carbon films with surface area exceeding 1000 m² g⁻¹ were obtained by reactions with Ar–Cl₂ gas at 600–1000 °C. Based on Raman spectroscopy and electron diffraction data, these films were identified as nanocrystalline graphite. An addition of hydrogen to the gas mixtures results in the etching of graphitic carbon. Traces of diamond were found along with amorphous carbon after treatment in Ar–Cl₂–H₂ gas mixtures at temperatures above 900 °C.

Introduction

Recently, formation of carbon by hydrothermal corrosion of SiC and other carbides at 300–800 °C has been found. The synthesis of carbon coatings on the surface of carbides by hydrothermal leaching was also reported. The formation of both graphitic and tetrahedral carbon on the surface of SiC by hydrothermal methods has also been observed. However, hydrothermal treatment can only be applied to carbides that form soluble or volatile hydroxides, such as Si(OH)₄. Even for SiC, co-deposition of silica can occur during the treatment. Extraction of metals from carbides by halogen compounds (F₂, Cl₂, Br₂ and I₂) or their compounds (HF, CCl₄, CHCl₃, etc.) can also lead to the formation of free carbon which may have a similar structure to that of the hydrothermal carbon. This method is more versatile because it can be used to obtain carbon from various carbides, since most of metals form volatile halides (e.g., TiCl₄, TiI₄, etc.), but do not form soluble or volatile oxides. For SiC, it has been reported that the Si-component is preferentially attacked and a carbon-rich layer builds up in the reaction with chlorine or fluorine-containing gases. However, there is no published information about the structure and properties of carbon films produced by this method. This carbon formation was observed primarily by researchers studying corrosion or etching of semiconductor materials so the properties of the carbon residue were not of importance. Under some conditions, the presence of halogens may favor diamond formation. Grannen and Chang were able to form a diamond deposit from fluorocarbon gases in a microwave plasma on β-SiC and WC without diamond pretreatment of the substrate. Halogenated hydrocarbons can serve as precursors for both CVD and hydrothermal synthesis of diamond.

Here, we present the results of the treatment of a β-SiC powder with chlorine-containing gases and thermodynamic simulations of possible reactions.

Thermodynamic study

The interaction of SiC with chlorine–oxygen gas mixtures has been previously studied. Here, thermodynamic analyses of the reaction products in the system β-SiC/chlorine-containing gases have been conducted in the temperature range 300–1300 °C using a Gibbs energy minimization program. The HSC program developed by Outokumpu Research Oy, Finland at the University of Illinois and Chem sage-3.11 program (GTT Technologies, Germany) at the University of Tübingen were used. The calculations were made in the temperature range from 300 to 1300 °C in 50 °C increments for the following systems:

1. SiC + Cl₂(g), at 1 atm;
2. SiC + Cl₂(g) + H₂(g), at 1, 100 and 1000 atm; and
3. SiC + 0.9 Cl₂(g) + H₂(g) + 0.1 O₂, at 1 atm.

Thus, the effects of temperature, pressure, H₂:Cl₂ ratio and oxygen contamination on the composition of equilibrium reaction products have been studied. The effect of the presence of Ar was also investigated in this simulation.

The hypotheses necessary to carry out the thermodynamic calculations concern the choice of the gas and solid phases and the choice of thermodynamic data. The calculations were done for a closed system with constant total pressure and ideal gases (activity coefficients are equal to unity). More than 60 possible species were taken into account.

The method used for thermodynamic calculations assumes that equilibrium conditions are reached between the gas phase and the solid at the reaction surface. However, kinetic limitations lead to relatively low corrosion rates of carbide samples at temperatures below 400 °C. The calculations have been done for a closed system. However, the experiments were performed in an open system with gases flowing through a tube reactor. Thus, the calculated equilibrium composition was not always reached under the conditions of the experiments. Therefore, comparison of the results of the thermodynamic calculations with the experimental data must be performed with account of the possible differences between the equilibrium and nonequilibrium conditions.

Materials and Experimental procedure

The β-SiC powder used in this experiment (Johnson Matthey, MA) is of 99.8% purity with 1 μm particle size. The X-ray diffraction (XRD) pattern of the as-received powder shows typical β-SiC peaks. The Raman spectrum displays a strong Raman band at 1340 cm⁻¹ due to transversal optical (TO) phonons of β-SiC and another weak band at 1500 cm⁻¹ which can be ascribed to C–C bonds in SiC. The shape of the spectrum is typical for disordered fine grain β-SiC. The spectrum of the as-received powder also contains some free carbon as indicated by two bands at 1570 and 1324 cm⁻¹. The former is referred to as the G mode and attributed to doubly degenerated E₂g in-plane stretching mode of graphite. The latter originates from phonon scattering from the boundary of

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the graphite Brillouin zone and is referred to as the D mode of graphite. It is known to be active in small graphite crystallites, as the grain size becomes of the same order as the incident phonon wavevector. Its position depends on the excitation wavelength and is observed at 1350–1355 cm\(^{-1}\) for the 514.5 nm excitation line of an Ar laser and at ca. 1325 cm\(^{-1}\) for the 632.8 nm line of the He–Ne laser. Both TEM and micro-Raman studies demonstrated the presence of traces of carbon as inclusions with size <1 \(\mu\)m.

Experiments to produce carbon by reaction with chlorine were performed in the apparatus shown schematically in Fig. 1. The gases H\(_2\) and Cl\(_2\), supplied in premixed cylinders with argon, were purified to remove H\(_2\)O and CO\(_2\) by passage through packed columns of anhydrous CaSO\(_4\) and Ascarite and mixed in a packed column. The gas flow rate was 1.5 cm\(^3\) s\(^{-1}\) in the reaction tube. Powdered \(\beta\)-SiC was contained in a platinum foil crucible suspended in the hot zone of the furnace. Experiments were continued for 5–72 h depending on the reactivity of the environment. Gas mixtures containing 2–3.5\% Cl\(_2\) and 0–2\% H\(_2\) at temperatures from 500 to 1000 °C were used. Although argon was always present as the main component of the gas mixture, it was an inert addition. Therefore, when describing the gas composition in the text, we shall ignore the presence of argon and mention only H\(_2\) and Cl\(_2\) contents in the mixture.

After treatment with gases, the powders were investigated by XRD, scanning electron microscopy (SEM), X-ray energy dispersive spectroscopy (EDS), FTIR spectroscopy, transmission electron microscopy (TEM) and Raman spectroscopy. The use of all of the above methods to analyze the reaction products in the Si–C–O system and the problems encountered in doing so were discussed in detail by Gogotsi et al.\(^{16}\)

A Siemens-5000 X-ray diffractometer with Cu-K\(\alpha\) radiation was used for X-ray diffraction analysis. A JEM 35C (JEOL, Japan) scanning electron microscope was used for SEM and EDS analyses. The Raman analyses were conducted using a LabRam II micro-Raman spectrometer (Dilor, France) at the University of Tübingen, Germany. An Ar ion laser at a wavelength of 514.5 nm and a He–Ne laser at a wavelength of 632.8 nm were used for Raman analysis of the powders. The powders were placed on an aluminium foil or a glass plate for micro-Raman measurements. The spectra were obtained using magnifications of \(\times 1000\ \times 100\) objective lens and \(\times 100\ \times 10\) objective lens. The wavenumber range from 200 to 1800 cm\(^{-1}\) was covered. All phases which exist in the Si–C–O system have Raman bands in this range. Spectra from selected samples were recorded in the range from 50 to 7000 cm\(^{-1}\). At least ten measurements were done on each powder to obtain reliable and reproducible spectra.

FTIR studies were conducted using a Bruker spectrometer at the University of Tübingen. Samples for FTIR spectroscopy were prepared by mixing the powders with KBr and pressing to form a pellet. The volume-filling factor of the powder was 0.005. FTIR absorption spectra were measured in the frequency range 400–4000 cm\(^{-1}\).

Three samples after treatments under different conditions were chosen for TEM analysis. The powders were observed in a JEM 200CX transmission electron microscope operating at 200 kV. This analysis was carried out at the center for Materials Research, University of Oslo. The particle types were identified by selected area diffraction (SAD) patterns. TEM samples were prepared by mixing powders with ethanol in an ultrasonic bath, followed by filtration of the particles which were collected on a supporting copper grid covered with a perforated carbon film.

After the treatment of the powder, the surface area was measured by the BET method. To measure the total content of carbon formed the treated samples were oxidized at 750 °C in air at atmospheric pressure. The mass change after oxidation was measured.

**Results**

**Thermodynamic simulations**

From the results shown in Fig. 2–5, carbon formation is expected in reactions with both Cl\(_2\) and Cl\(_3\)–H\(_2\). In the system of SiC/Cl\(_2\), the reaction

\[
\text{SiC} (g) + 2 \text{Cl}_2 (g) = \text{SiCl}_4 (g) + \text{Si} (s)
\]  

is rather slow. The reaction

\[
\text{SiC} + 2 \text{Cl}_2 = \text{SiCl}_4 (g) + \text{C} (s)
\]  

is most favorable thermodynamically and at higher temperature (above 900 °C), the thermodynamic probability of the reaction

\[
\text{SiC} (s) + 2/3 \text{Cl}_2 = \text{SiCl}_3 (g) + \text{C} (s)
\]  

increases. The probability of CCl\(_4\) formation decreases with

![Fig. 1 Schematic diagram of the apparatus for etching in chlorine-containing gases. 1.3: H\(_2\)SO\(_4\); 2.6: desiccant; 4.8: capillary flowmeter; 5.7: dibutyl phthalate; 9: mixing column; 10: quartz reaction tube; 11: resistance furnace; 12: Pt dish and quartz wire; 13: thermocouple.](Image 51x115 to 267x310)

![Fig. 2 Equilibrium reaction products, calculated by HSC for P=1 atm and molar ratio Cl\(_2\):SiC=1:1](Image 297x98 to 506x249)
Fig. 5 FTIR spectra of β-SiC powders treated in (a) Ar–3.5% Cl\textsubscript{2} at 1000 °C for 20 h and (b) Ar–2.6% Cl\textsubscript{2}–1.3% H\textsubscript{2} at 950 °C for 72 h.

increases with increasing H\textsubscript{2}:Cl\textsubscript{2} ratio. The yield of methane, which is unstable at high temperatures, decreases with increasing temperature so that the carbon yield increases. The carbon and hydrogen yields pass through a maximum, and at higher temperatures, the amount of HCl increases rapidly and that of carbon decreases. The maximum hydrogen and carbon contents in the reactor are obtained around 800 °C in the SiC/Cl\textsubscript{2}–H\textsubscript{2} system as shown in Fig. 3.

At higher temperature, the temperature at which the carbon content in the reaction products is maximized, increases as shown in Fig. 4. This is due to the increasing stability of methane and other hydrocarbon species formed at high pressure. A small addition of oxygen leads to the formation of silica (quartz), but does not affect the relative amounts of other species in the system as shown in Fig. 3(b).

When argon is present in the gas mixture, the temperature that corresponds to the maximum hydrogen and carbon contents in the reactor decreases to around 500 °C. This is similar to the effect of decreasing total pressure.

Experimental studies

The chlorination kinetics of SiC has been described in a recent publication\textsuperscript{17} and will not be discussed here. A mass loss was observed in agreement with the thermodynamic predictions.

XRD. After a treatment in 3.5% Cl\textsubscript{2} at 600 °C, the XRD pattern was much the same as that of the as-received powder. After reactions with 3.5% Cl\textsubscript{2}–Ar at 800 and 1000 °C the intensity of β-SiC reflections diminished and disappeared with increasing reaction time. However, no other peaks were detected. In the sample treated with Cl\textsubscript{2}–H\textsubscript{2} mixed gases, only β-SiC Bragg reflections were detected without any other signals present.

SEM and EDS. For the experiment with 3.5% Cl\textsubscript{2} at 1000 °C, EDS showed a substantial increase in the C:Si ratio compared to the untreated powder. However, the amount of oxygen was below the sensitivity of the method. For treatment with 2% Cl\textsubscript{2}–2% H\textsubscript{2} at 1000 °C, the intensity of β-SiC reflections diminished and disappeared with increasing reaction time. However, no other peaks were detected. In the sample treated with Cl\textsubscript{2}–H\textsubscript{2} mixed gases, only β-SiC Bragg reflections were detected without any other signals present.

FTIR spectroscopy. IR spectroscopy is useful for analysis of Si–O and C–H bonding, but its sensitivity to free carbon is relatively low.
low. Pure diamond does not have any IR-active modes. IR bands corresponding to C=–C bonds are weak compared to those of Si–C or Si–O bonds. Therefore, this analysis was primarily used to detect silica in the samples.

Silica was detected in all samples treated in Cl\textsubscript{2}–H\textsubscript{2} as shown in Fig. 5. The silica band at ca. 1100 cm\textsuperscript{−1} became much stronger compared to that of as-received powder and it also increased as the Cl\textsubscript{2}–H\textsubscript{2} ratio increased. However, silica was not found in the powders treated with 3.5% Cl\textsubscript{2} at 800 or 1000 °C. The results are in agreement with the EDS data. Although oxygen was not detected in the particles treated at 800 and 1000 °C by EDS and FTIR spectroscopy, in this case, silica was found around the Pt dish or on the sample suspension wire. At temperatures above 800 °C, after Si is etched from SiC by Cl\textsubscript{2}, the SiCl\textsubscript{4}(g) reacts with O\textsubscript{2}(g) to form SiO\textsubscript{2} or SiO. Silicon oxychloride compounds (Si\textsubscript{6}O\textsubscript{5}Cl\textsubscript{3} and Si\textsubscript{2}O\textsubscript{Cl}) can also be formed during the high-temperature reaction of SiC with Cl\textsubscript{2}–O\textsubscript{2} mixtures.\textsuperscript{18} Besides silica, sp\textsuperscript{3} carbon (bands at ca. 1580–1630 cm\textsuperscript{−1}) was detected in powders treated with Cl\textsubscript{2}–H\textsubscript{2} at 950 °C and with 3.5% Cl\textsubscript{2} at 1000 °C. The amplitude of the band was much higher in the latter case, as shown in Fig. 5. The former one shows a similar amplitude of the carbon band to that of untreated powder. Bands corresponding to CH\textsubscript{n} vibrations were observed in the wavenumber range 2850–3000 cm\textsuperscript{−1}.

**Raman spectroscopy.** In the spectra of the powders treated in 3.5% Cl\textsubscript{2} at 600 and 1000 °C, bands of disordered graphite were observed as shown in Fig. 6 along with β-SiC and amorphous silica. Here, the relative intensity of the G band of graphite compared to the D band increases with temperature. This implies that the size of the graphite crystallites increases as temperature increases. For evaluation of the graphite crystal size (in-plane dimension) \( L_a \) we used the equation,\textsuperscript{20}

\[
L_a = 4.4 \left( \frac{I_D}{I_G} \right)^{-1}
\]

where \( L_a \) is the size of graphite crystallites in nm and \( I_D \) and \( I_G \) are intensities of D and G bands of graphite, respectively.

The results are summarized in Table 1. The average size of graphite crystallites formed in the treatment with 3.5% Cl\textsubscript{2} was estimated as 2–4 nm.

While a strong SiC band was observed in the spectrum of the powder treated at 600 °C, in the powder treated at higher temperatures (1000 °C), the SiC band disappeared and only carbon bands were found, as shown in Fig. 6(b). From this, we can conclude that the carbon yield increases with temperature. These results are in agreement with XRD and EDS data.

Fig. 7 shows the Raman spectra of the powder treated in Cl\textsubscript{2}–H\textsubscript{2} mixture gases. Overall in these Raman spectra, a strong SiC band was observed in the spectrum of In experiments with 2%Cl\textsubscript{2}–2%H\textsubscript{2} at 800 °C [Fig. 7(a)], a broad band appeared, probably due to the superposition of the D band of graphite, the G band, and a band at 1500 cm\textsuperscript{−1}. The latter has been observed in carbon-rich SiC:H alloy or SiC.\textsuperscript{15}

![Fig. 6 Typical Raman spectra (excitation line 632.8 nm) of β-SiC powders treated in Ar–3.5% Cl\textsubscript{2} at (a) 600 °C for 27 h and (b) 1000 °C for 20 h](image)

![Fig. 7 Typical Raman spectra (excitation line 514.5 nm) of β-SiC powders treated in (a) Ar–2% Cl\textsubscript{2}–2% H\textsubscript{2} at 800 °C for 24 h, (b) Ar–2% Cl\textsubscript{2}–2% H\textsubscript{2} at 950 °C for 24 h and (c), (d) Ar–2.6% Cl\textsubscript{2}–1.3% H\textsubscript{2} at 800 °C for 24 h (two examples)](image)

Table 1  Surface area and size of graphite crystallites in SiC powders treated in Ar–Cl\textsubscript{2} and Cl\textsubscript{2}–H\textsubscript{2} gases

<table>
<thead>
<tr>
<th>experimental conditions</th>
<th>( T/°C )</th>
<th>( t/h )</th>
<th>( S' /\text{m}^2 \text{ g}^{-1} )</th>
<th>mass% C</th>
<th>( S_c/\text{m}^2 \text{ g}^{-1} )</th>
<th>( L_a/\text{nm} )</th>
</tr>
</thead>
<tbody>
<tr>
<td>3.5% Cl\textsubscript{2}–Ar</td>
<td>600</td>
<td>27</td>
<td>47.8</td>
<td>8</td>
<td>400</td>
<td>2.0–2.5</td>
</tr>
<tr>
<td>3.5% Cl\textsubscript{2}–Ar</td>
<td>600</td>
<td>48</td>
<td>140.0</td>
<td>11</td>
<td>1163</td>
<td>2.4–2.6</td>
</tr>
<tr>
<td>3.5% Cl\textsubscript{2}–Ar</td>
<td>1000</td>
<td>20</td>
<td>989.6</td>
<td>98</td>
<td>1010</td>
<td>2.0–4.5</td>
</tr>
<tr>
<td>2% Cl\textsubscript{2}–2% H\textsubscript{2}–Ar</td>
<td>1000</td>
<td>72</td>
<td>11.5</td>
<td>&lt;5%</td>
<td>10</td>
<td>1.0–4.5</td>
</tr>
<tr>
<td>as-received β-SiC</td>
<td></td>
<td></td>
<td>13.6</td>
<td>&lt;3%</td>
<td></td>
<td>2.0</td>
</tr>
</tbody>
</table>

\( S' = \)Specific surface area of powder. \( S_c = \)Calculated surface area of carbon.

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Fig. 9 Full Raman spectrum (excitation line 514.5 nm) of the diamond region in the β-SiC powder treated in Ar–2.6% Cl₂–1.3% H₂ at 950 °C for 24 h

Fig. 10 Typical Raman spectra (excitation line 632.8 nm) of β-SiC powders treated in (a) Ar–2% Cl₂–2% H₂ at 1000 °C for 72 h and (b) Ar–2.4% Cl₂–1.5% H₂ at 950 °C for 72 h

Fig. 11 Bright field TEM micrograph showing the carbon film on a region of diamond phonon (1332 cm⁻¹) and an extremely weak G band of graphite were observed. A very weak band at ca. 1130 cm⁻¹ may correspond to amorphous diamond. Very similar spectra were obtained from the powder treated with 2.6% Cl₂–1.3% H₂ at 950 °C. A broad band at 1140 cm⁻¹ which is ascribed to amorphous diamond was observed along with another broad band at around 1330 cm⁻¹. Similar spectra were also obtained from nanocrystalline CVD diamond.

The presence of filamentous carbon and graphite whiskers (Fig. 12) demonstrates the importance of carbon transport via the gas phase. Some of the whiskers show ring diffractions that may be ascribed to amorphous silica. Thus, those may be silica whiskers covered with a carbon film. The thicker and highly oriented graphite films, as shown in Fig. 13, were detected in the sample that was treated under similar conditions at 1000 °C. The TEM micrographs show that as the temperature increases, thicker and more highly ordered carbon

TEM. Numerous carbon particles and graphitic carbon films on the surface of SiC particles have been found in the sample treated with 3.5% Cl₂–Ar at 600 °C as shown in Fig. 11. At the same time, the presence of filamentous carbon and graphite whiskers (Fig. 12) demonstrates the importance of carbon transport via the gas phase. Some of the whiskers show ring diffractions that may be ascribed to amorphous silica. Thus, those may be silica whiskers covered with a carbon film. The thicker and highly oriented graphite films, as shown in Fig. 13, were detected in the sample that was treated under similar conditions at 1000 °C. The TEM micrographs show that as the temperature increases, thicker and more highly ordered carbon
films grow due to reaction with the Cl$_2$ atmosphere. These films produce diffraction patterns of graphite [Fig. 13(c)].

Uniform carbon films were rarely present on the surface of $\beta$-SiC particles treated with 2% Cl$_2$–2% H$_2$ at 1000 °C. The amount of carbon was small and $\beta$-SiC was the main constituent. Selected area diffraction (SAD) patterns show reflections at $d=0.206$ nm in carbon-containing regions (Fig. 14). These can be ascribed to diamond. However, no well shaped diamond particles were found. This confirms that the broad bands in the diamond region, which were observed in Raman analyses, could arise from nanocrystalline diamond.

**BET.** Results of BET specific surface area measurements are shown in Table 1. It can be seen that the powder treated at 1000 °C in Cl$_2$ has a specific surface area of about 1000 m$^2$ g$^{-1}$. This value is typical for active carbons. Other experiments with Cl$_2$ produced powders with surface areas of 100–200 m$^2$ g$^{-1}$. However, these powders contained various amounts of non-reacted SiC. To determine the carbon content in the powders, the samples treated with the Cl$_2$ gas were oxidized in air in the temperature range from room temperature to 750 °C and the mass changes were measured by TG. The results (Table 1) show that the surface area increases with the increasing carbon content. Based on the SEM and TEM observations, we assume that the treatments did not change the shape of SiC particles and, respectively, did not affect the surface area of SiC nuclei. Thus, the observed increase in the specific surface was in all cases due to carbon coatings formed on SiC. Using the measured specific surface of powders and carbon content we calculated the specific surface of carbon as follows

$$S_c = (S - (S_{\text{SiC}})(100 \text{ mass}\% \text{C}))/\text{mass}\% \text{C}$$

where $S$ is the measured specific surface area of the powder, $S_{\text{SiC}}$ is the specific surface area of as-received SiC powder and mass% C is the carbon content in the powder.

We found that all porous carbon coatings on SiC particles have a high surface area, but the surface area increases with increasing time and/or temperature of the treatment in Cl$_2$ (Table 1).

Treatments in Cl$_2$–H$_2$ atmospheres did not increase the surface area of the powder. Still, small amounts of carbon were formed in agreement with thermodynamic calculations as confirmed by Raman analysis and TEM. A low surface area
in the latter case led us to the conclusion that a different structure of the carbon was formed after treatment in Cl₂–H₂.

Discussion

We can divide all experiments into two groups: Cl₂ treatment and Cl₂–H₂ treatment.

Interaction with Cl₂

In the first group of experiments (Cl₂ environment), large amounts of carbon were formed as indicated by EDX and Raman spectra in accord with the results of our thermodynamic calculations and previous reports. This was amorphous carbon or nanocrystalline graphite film as shown by XRD, Raman spectroscopy and TEM. As the temperature increased, the thickness of the carbon films increased as shown in the TEM micrographs (Fig. 11 and 13).

In the XRD analysis, the condensed carbon phases were not detected probably owing to their amorphous or nanocrystalline state. Graphite or diamond must have a crystal size of above 10 nm and be present in a quantity of several percent to show an XRD pattern. The calculated size of graphite crystallites in our experiments is < 5 nm (Table 1).

At 800–1000 °C, the carbon formed from Cl₂ treatments has a surface area of > 1000 m²/g⁻¹. The specific surface area of 1000 m²/g⁻¹ is close to the maximum surface area of carbon, since the calculated surface area for an extended graphite layer plane, counting both sides, is about 2800 m²/g⁻¹. Taking into account the measured specific surface area and TEM observations (Fig. 11, 13), which do not reveal the porosity in carbon films even at > 350 000 × magnification, we can assume that the pore size is < 1 nm. According to the classification scheme outlined in ref. 23, this is a microporous carbon (although the term ‘subnanoporous’ would be more exact). Carbon with a comparable surface area and pore size can be obtained, for instance, by steam activation of anthracite. More detailed consideration of the pore structure of carbon films is outside the scope of this paper.

It is important to note that the formation of carbon is very uniform (Fig. 13) and does not change the shape of SiC particles. This suggests the growth of carbon by extraction of Si from SiC and collapse of the cubic structure of β-SiC to amorphous carbon. However, small amounts of carbon found on the surface of uniformly transformed layers could be deposited from the gas phase via such reactions as:

\[ \text{CCI}_4(g) + C(s) + 2 \text{Cl}_2(g) \]
\[ \text{CO}(g) = C(s) + 1/2 \text{O}_2(g) \]  

Interactions with Cl₂–H₂ mixtures

In the treatment with Cl₂–H₂ gas mixtures, a very low graphitization degree and size of graphite crystallites were observed (see Table 1). Calculations using eqn. (8) show that if the spectra shown in Fig. 10 (a) and (b) were ascribed to graphite, the calculated grain size (ca. 0.4 nm) would approach the unit-cell size (ca. 0.24 nm) of graphite. Thus, the above spectra should be due to the presence of disordered diamond (or its mixture with sp³ carbon) rather than graphite. Similar spectra were obtained from nanocrystalline diamond powders. By the thermodynamic calculation (Fig. 3), the amount of carbon should not be much smaller than that formed in a pure Cl₂ atmosphere (Fig. 2) and should increase linearly as the Cl₂–H₂ ratio increases. In these experiments much less carbon was formed in the Cl₂–H₂ atmospheres compared to Cl₂ treatment. In the case of 2% Cl₂–2% H₂ treatment at 1000 °C, the presence of crystalline diamond was confirmed by TEM. Considering that this powder shows only a broad Raman band in the diamond region as shown in Fig. 7, the presence of diamond in other samples treated in Cl₂–H₂ showing similar Raman spectra is likely as well. Fig. 7 shows rather sharp peaks at ca. 1330 cm⁻¹, which can arise from diamond. However, the simultaneous presence of graphite peaks makes it difficult to distinguish between the Raman band of disordered diamond and the D band of graphite and so the identification of diamond in these samples is not unambiguous. Since diamond was not detected in XRD analysis, it is likely that nanocrystalline diamond was present in very small quantities.

From the thermodynamic calculations it is expected that carbon film formation on β-SiC will occur upon etching in Cl₂ or Cl₂–H₂ mixture gases, and this was confirmed experimentally. The thermodynamic calculations do not distinguish between the conditions for amorphous sp² carbon and for diamond or sp³ carbon. However, in our experiments diamond or sp³ carbon formed only when hydrogen-chlorine mixture gases were used. The thermodynamic calculations do not predict that the amount of carbon formed in the reaction with Cl₂–H₂ is much less than that in pure Cl₂ above ca. 700 °C. However, in our experiments the difference was very significant as shown in all analyses. This may be because experiments performed in an open system permitted gasification of graphitic carbon due to its interaction with hydrogen. It is known that hydrogen plays an important role in diamond synthesis independent of the method. It was reported that sp³–C is formed on the β-SiC by hydrogen ion etching. In our experiment, sp³–C is formed in the treatment with the 2% Cl₂–2% H₂ and the 2.6% Cl₂–1.3% H₂ mixtures.

The formation of diamond can occur by two possible mechanisms. One is extraction of carbon from the structure of β-SiC, stabilization of dangling bond of carbon with hydrogen and further desorption of hydrogen with the formation of diamond. Molecular dynamics calculation shows that helium-filled silicon vacancies are energetically more stable as compared to unoccupied vacancies. The effect of hydrogen in stabilization of Si vacancies and thus the cubic structure of β-SiC when Si is extracted, is assumed to be the same. The above calculations showed that a Si atom can be spontaneously replaced by a carbon atom from the energy point of view. This shows how the SiC structure can be transformed into diamond. However, only very thin films or small particles can be formed this way due to obvious diffusion barriers through the growing diamond. Another possible mechanism is the deposition of diamond from the gas phase by decomposition of CCl₄(g) or CH₄(g) formed by reactions (1) and (7).

Such reactions, as for instance, eqn. (10) and (11) and

\[ \text{CH}_4(g) = C(s) + 2 \text{H}_2(g) \]

or

\[ \text{CCl}_4(g) + 2 \text{H}_2(g) = C(s) + 4\text{HCl}(g) \]

can result in diamond growth on the surface of SiC. Silicon carbide is widely used as a substrate for diamond depositions because of a partial matching between the diamond lattice (Fdash 3m space group) and the β-SiC lattice (Fdash 4m space group). The first mechanism can lead to diamond nucleation and the latter to its further growth.

This route to diamond growth is not surprising in view of the fact that first experiments on diamond growth by thermal decomposition of CBr₄ and Cl₄ at 900 °C were conducted 40 years ago. The importance of the use of initial carbon-containing molecules with sp³-bonding (as in the case of SiC) was stressed by Spitsyn. The major difference in our case is that we used SiC as a substrate and source of carbon simultaneously.

Potential applications

Carbon films find numerous applications in a wide range of fields. Although more detailed studies of the properties of
carbon films obtained on the surface of SiC may be necessary, we can suggest the following potential applications.

1. Weak carbon coatings on SiC fibers, whiskers and platelets can gradually improve the fracture toughness and work of fracture of ceramic matrix composites. Treatments in Cl₂ can be used to obtain coatings on any SiC reinforcement for composites.

2. Active carbon coatings on carbides may be of interest for catalysis and/or medical applications. Carbon materials with a high surface area are ideal as catalyst supports. Since the degree of porosity can be controlled by parameters of the treatment, materials with a specific adsorption capacity can be provided. Additionally, thin films of active carbon can be obtained on SiC fibers or fabrics, allowing the use of special shapes that cannot be obtained from natural carbons.

3. Since reduction of the SiC surface is possible, powders with improved sinterability may be obtained. About 0.5% of free carbon is usually added to SiC to enable its pressureless sintering. A uniform distribution of such a small amount of carbon is difficult, since any large inclusions can cause flaw formation and decrease in mechanical properties. Chlorination of SiC powders can produce very thin and uniform films that should be perfect for improving the sinterability.

4. The formation of diamond shows that if any activation method is used (plasma, hot wire or other technique), synthesis of diamond films on the surface of SiC should be possible without any carbon supply from the gas phase. This can be used as an alternative to CVD diamond synthesis or as a method of obtaining intermediate thin diamond (sp³-carbon) films for further CVD deposition of diamond on the surface of SiC and other carbides.

5. Both graphitic and diamond films are used in tribology to decrease coefficients of friction and improve wear resistance of sliding parts. A new methods of covering carbides with carbon films may be of practical importance for ceramic bearings and other tribological applications.

Conclusions

1. The formation of carbon upon interaction of silicon carbide with Cl₂ and Cl₂–H₂ gases was predicted. Carbon yield has a maximum in Cl₂–H₂ mixtures which shifts to higher temperatures with increasing pressure.

2. Uniform amorphous carbon or nanocrystalline graphite films were produced by the reaction of the β-SiC powder with chlorine gas at temperatures of 600–1000 °C and at atmospheric pressure. As temperature increases, the thickness of the film formed after a fixed period of exposure increases. The carbon films have a disordered structure with the surface area >1000 m²·g⁻¹ and porosity in the nanometer range. Small amounts of oxygen did not affect the formation of carbon films, but result in the simultaneous formation of amorphous silica.

3. When the hydrogen–chlorine gas mixture was used with an appropriate ratio of Cl₂ and H₂, traces of nano- or microcrystalline diamond were found.

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References


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